Receipt date: 04/21/2009 10514429 - GAU: 2881

> ALTERNATIVE TO PTO/SB/08A/B (Based on PTO 08-08 version)

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Subs	stitute for form 1449/PT	3		Application Number	10/514,429	
IN	FORMATIC	אל אל	SCLOSURE	Filing Date	July 12, 2005	
			APPLICANT	First Named Inventor	Robert DWILINSKI	
3	IVICAL	טו ר	di i Lioani	Art Unit	2881	
	(Use as many	sheets as	necessary)	Examiner Name	M. J. Logie	
Sheet	1	of	3	Attorney Docket Number	204552033800	

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Examiner Initials*	Cite No.1	Document Number  Number-Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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Examiner Initials*	Cite No.1	Foreign Patent Document  Country Code³-Number⁴-Kind Code⁵ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages Or Relevant Figures Appear	T°
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/Michael Logie/

04/28/2009

10514429 - GAU: 2881 Receipt date: 04/21/2009

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Sub	ostitute for form 1449/PT	0		Application Number	10/514,429	
IN	JEORMATIC	וח אנ	SCLOSURE	Filing Date	July 12, 2005	
STATEMENT BY APPLICANT				First Named Inventor	Robert DWILINSKI	
3	IAILMLNI	ייט י	ALL LIOAN	Art Unit	2881	
	(Use as many sheets as necessary)			Examiner Name	M. J. Logie	
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NON PATENT LITERATURE DOCUMENTS					
Examine r Initials	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T²		
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/Michael Logie/

04/28/2009

Receipt date: 04/21/2009

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Su	bstitute for form 1449/PT	го		Application Number	10/514,429	
11	NFORMATION	ON DISC	CLOSURE	Filing Date	July 12, 2005	
	TATEMEN			First Named Inventor	Robert DWILINSKI	
0	HIEWIEN	DIA	LICANI	Art Unit	2881	
	(Use as many	sheets as ne	ecessary)	Examiner Name	M. J. Logie	
Sheet	3	of	3	Attorney Docket Number	204552033800	

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Signature / Michael Logie/ Considered 04/28/2009	Examiner Signature	/Michael Logie/	Date Considered	04/28/2009
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<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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